Electronic Supplementary Information for Amphoteric Doping in CulnTe₂

Vanessa Meschke,[†] Angela Pak,[‡] Jesse M. Adamczyk,[†] Lídia C. Gomes,[‡]

Samantha M. Baumann,[¶] Grace A. Rome,[¶] Claire Porter,[†] Kamil Ciesielski,[†] Elif

Ertekin,[‡] and Eric S. Toberer^{*,†}

 †Department of Physics, Colorado School of Mines, Golden, CO, USA
 ‡Department of Mechanical Science and Engineering, University of Illinois Urbana Champaign, Champaign, IL USA
 ¶Department of Materials and Metallurgical Engineering, Colorado School of Mines,

Golden, CO USA

E-mail: etoberer@mines.edu

SEM Images and X-ray Diffraction Patterns

The following figures show SEM images and the x-ray diffraction (XRD) patterns of the pellets studied in this work. The XRD patterns are referenced to the chalcopyrite structured CuInTe₂ (space group 122, $I\bar{4}2d$) from Collection Code 73352 in the Inorganic Crystal Structures Database.



Cu_{0.96}InTe₂

Figure S1: SEM image showing high density microstructure and single phase behavior. The low fraction of pores will not significantly impact transport behavior. XRD shows only the CuInTe₂ phase. Te concentration in the EDS measurements is low as a result of instrumental error.



Figure S2: Zn doped CuInTe₂ showing single phase behavior in both SEM and XRD. Porosity will only have a minimal effect on the electronic transport properties.



Figure S3: Zn doped CuInTe₂ showing single phase SEM and XRD behavior.



Figure S4: Zn doped CuInTe₂ showing minor porosity and single phase behavior.

Table S1: Lattice parameters of native and doped $CuInTe_2$ from Rietveld refinements. Average grain sizes are relatively large and will not have a major effect on electronic transport.

Sample Composition	a (Å)	c (Å)	Average Grain Size (μm)
$Cu_{0.96}InTe_2$	6.211905	12.358688	43
$Cu_{0.96}InTe_2Zn_{0.04}$	6.22055	12.355338	24
$CuIn_{0.96}Te_2$	6.218583	12.404658	39
$CuIn_{0.96}Te_2Zn_{0.04}$	6.215596	12.397016	27

Speed of Sound

Table S2: Longitudinal and shear speed of sound of native and doped $CuInTe_2$.

Sample Composition	Longitudinal (m/s)	Shear (m/s)
$Cu_{0.96}InTe_2$	3531	1826
$Cu_{0.96}InTe_2Zn_{0.04}$	3561	1845
$CuIn_{0.96}Te_2$	3334	1789
$CuIn_{0.96}Te_2Zn_{0.04}$	3501	1835

Selection of Zn chemical potential

Selection of the chemical potential and synthesis temperature for the CIT space is a delicate process given the sensitivity of the system to perturbations in defect concentrations. In this case, we can see that a $\Delta \mu_{\rm Zn} = -1.38 \text{ eV}/\text{atom}$ and $T_{\rm synth} = 623 \text{ K}$ matches for point CT2 well (expected carrier concentrations of 1×10^{19} and $5 \times 10^{19} \text{ cm}^{-3}$ for the undoped and doped cases, respectively, shown with the horizontal dashed yellow lines). For point IT1, $\Delta \mu_{\rm Zn} = -1.25 \text{ eV}/\text{atom}$ and $T_{\rm synth} = 623 \text{ K}$ matches the experimental data well (expected carrier concentrations of 3×10^{19} and $4 \times 10^{15} \text{ cm}^{-3}$ for the undoped and doped cases, respectively, shown in the horizontal, navy dashed lines).



Figure S5: For each invariant point from the original phase equilibria space, the measured carrier concentrations at 323 K is highly sensitive to the chemical potential of Zn (color) as well as synthetic temperature (x-axis).

Defect diagrams

Undoped Defect Diagrams

The defect diagrams for the undoped samples are shown below. The summary of these diagrams is shown in the main text in the Brouwer diagram. A synthetic temperature of 623 K was selected for these diagrams.



Figure S6: Defect diagrams for native defects in $CuInTe_2$ corresponding to the six invariant points (three-phase equilibrium points) in chemical potential space.

Doped Defect Diagrams

Defect diagrams for varying levels of $\Delta \mu_{Zn}$ are shown for the chemical potentials that were chosen by assessing the curves in S5.

$\Delta \mu_{ m Zn} =$ -1.25 eV/atom

Defect diagrams for doped CuInTe₂ doped with Zn for a chemical potential $\Delta \mu_{\rm Zn} = -1.25$ eV/atom and a synthetic temperature of 623 K. The Fermi level at synthesis (E_F^{def}) and at measurement temperature (E_F^{eq}) are inside the valence band for points CT1 and CT2. CT1 has $E_F^{def} = -0.16$ eV and $E_F^{eq} = -0.18$ eV, and CT2 has $E_F^{def} = -0.06$ eV and $E_F^{eq} = -0.08$ eV.



Figure S7: Defect diagrams for defects in CuInTe₂ doped with Zn corresponding to the six invariant points (three-phase equilibrium points) in chemical potential space. These plots are shown for $\Delta \mu_{Zn} = -1.25 \text{ eV}/\text{atom}$ and $T_{synth.} = 623 \text{ K}$.

$\Delta \mu_{\rm Zn} =$ -1.38 eV/atom

For point CT2, a synthetic temperature of 623 K and a $\Delta \mu_{Zn} = -1.38 \text{ eV}/\text{atom}$ best matched the experimental data. The Brouwer band diagram and defect diagrams are shown for these conditions below.



Figure S8: Brouwer diagram for Zn-doped CuInTe₂ at $\Delta \mu_{Zn} = -1.38 \text{ eV}/\text{atom}$ and T_{synth} = 623 K.



Figure S9: Defect diagram for defects in CuInTe₂ doped with Zn with $\Delta \mu_{Zn} = -1.38 \text{ eV}/\text{atom}$ and $T_{synth} = 623 \text{ K}$.

Table S3: Three-phase equilibrium points predicted from DFT calculations for CuInTe $_2$ doped with Zn.

Invariant point	$\Delta \mu_{Cu}$	$\Delta \mu_{In}$	$\Delta \mu_{Te}$	Phases
CI1	0	-0.438	-0.649	$Cu, Cu_{11}In_9$
CI2	-0.242	-0.143	-0.675	$Cu_{11}In_9$, In_4Te_3
CI2'	-0.312	-0.185	-0.619	$In_4Te_3, CuIn_5Te_8$
IT1	-0.622	-1.11	0	$CuIn_5Te_8$, Te
CT1	-0.321	-1.414	0	Te, CuTe
CT2	0	-1.093	-0.321	CuTe, Cu



Figure S10: Thermoelectric figure of merit (zT) shows little variation in the majority of the samples studied in this work. However, the Zn-doped copper-deficient sample shows poor zT due to its low carrier concentration.

Total Thermal Conductivity



Figure S11: Total thermal conductivity measurements closely follow the κ_l data presented in the main text, indicating minimal electronic contributions to the overall thermal conductivity.